

**Notice of References Cited**

Application/Control No.

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Applicant(s)/Patent Under  
Reexamination  
NISHIDA ET AL.

Examiner

Alain L. Bashore

Art Unit

1762

Page 1 of 1

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	U	Machine english translation for portion of Japanese patent publication H09-073001; JPO, October 2007.
	V	Machine english translation for portion of Japanese patent publication H09-165231; JPO, October 2007.
	W	Machine english translation for portion of Japanese patent publication H10-186104; JPO, October 2007.
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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